## Notice of References Cited Application/Control No. 10/813,974 Examiner Khai N. Nguyen Applicant(s)/Patent Under Reexamination HUEY, CHRISTOPHER A. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,385,312	05-2002	Shaffer et al.	379/211.02
*	В	US-2003/0087647 A1	05-2003	Hurst, Michael	455/456
*	С	US-2001/0028649 A1	10-2001	Pogossiants et al.	370/389
*	D	US-2003/0086539 A1	05-2003	McCalmont et al.	379/45
*	Ε	US-6,128,481	10-2000	Houde et al.	455/404.2
*	F	US-2005/0174991 A1	08-2005	Keagy, Scott	370/352
*	G	US-2004/0229620 A1	11-2004	Zhao et al.	455/445
*	Н	US-6,473,505	10-2002	Khuc et al.	379/265.01
	1	US-			
	J	US-			
	К	US-			
	L	US-	1		
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
	R					
L	s		•			
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.